

# SOFC Development at PNNL: Overview

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# **Scope of Work**

- Core Technology Program
  - Materials Development
    - ✓ Cathode materials and interactions
      - Effects of volatile species (Cr, Sr) on cell performance
      - Mitigation of Cr poisoning: Evaluation of Cr capture materials
      - Cathode contact materials: Enhancing reliability of cathode/contact materials interfaces
    - ✓ Interconnects/BOP
      - Co-free protective coatings for metallic interconnects
  - Modeling/Simulation
    - ✓ SOFC Stack and System Modeling Tool Development
    - ✓ Modeling of Stack Degradation and Reliability
- Small-Scale SOFC Test Platform
  - Evaluation of performance and reliability of new stack technologies (1-10 kW)



# **Cr** Poisoning

- Challenges
  - Developing an understanding of the effects of Cr poisoning on phase formation in and atomic structure of SOFC cathodes
  - Mitigation of effects of volatile Cr species on cathode performance
- Approaches
  - In-operando XRD of LSM and LSCF-based cathodes with various Cr concentrations in the cathode air stream
  - Evaluation/optimization of Cr "getter" materials intended to capture volatile Cr species
    - ✓ May be located upstream of stack and/or within stack ("on-cell" capture)
    - $\checkmark$  Possibly use upstream getter as primary, and "on-cell" getter as secondary ("polishing")



# **Cr Poisoning: In-operando XRD**



- A hydrogen safety incident at PNNL prompted safety upgrades to all experiments using hydrogen.
- Safety upgrades for in-operando XRD of SOFCs were installed:
  - Metallic lines for flammable gases
  - Over temperature monitoring
  - Fume hood pressure monitoring
  - Flammable gas sensing
  - Automatic shut down

Baseline test on LSCF cell in dry, clean air was recently completed – XRD analysis pending



## Poster: SOFC Development at PNNL: Cathode Task (Brent Kirby)

0°C, Dry	Air		
) ours)	800	1000	1200



# **Cr Gettering Materials**

- In previous work, LSCF perovskites with high Sr content were shown to be effective as upstream getters due to high reactivity with Cr vapor species (forming SrCrO<sub>4</sub> as reaction product).
- For <u>on-cell applications</u>, Cr-gettering material needs to have matched CTE, high electrical conductivity, chemical compatibility, and thermal stability.
- Approach: Evaluate LSCF/LSM and LSCF/LSCo mixtures as dual purpose cathode contact / Cr getter materials.





# **Cr Gettering Materials: LSCF/LSM Validation Testing**

No Cr Getter:





80% LSCF / 20% LSM: On-cell Getter



cell 262, ASC3, LSM/4628 (20%) wet air

8.9%/kh

1200 1500 1800



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# **Cr Gettering Materials: LSCF/LSCo Characterization**



Pacific

Northwest

Poster: Mitigation of Cr poisoning - An Investigation of LSCo/LSCF Composite (Matt Chou)

# Vapor Transport of Species from LSCF Cathodes



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• Early tests configured as above indicated transport of Sr and Co





- Subsequent tests designed for long surface diffusion paths (above) between cathode material and substrate sink indicated no appreciable Sr and Co transport
- Open geometry may have limited the concentration of vapor phases, thus new fixture was designed with long surface paths and enclosed chamber
- Next tests are pending

## Poster: SOFC Development at PNNL: Cathode Task (Brent Kirby)



# **Cathode / Interconnect Contact Materials**

- Challenge
  - Electrical contact materials at cathode / interconnect interfaces in planar stacks tend to be mechanical "weak link," especially during thermal cycling, due to brittle nature of ceramic materials and/or thermal expansion mismatch with adjacent components
    - $\checkmark$  Low processing temperatures and constrained sintering conditions during stack fabrication lead to low intrinsic strength and low bonding strength of ceramic contact materials, especially at contact-tocathode interface
    - ✓ Use of metallic contact materials limited by cost, volatility, and/or electromigration
- Approach
  - Use composite approach to develop ceramic-based contact materials having improved mechanical reliability by reducing thermal expansion mismatch and increasing contact strength/toughness



# LSCo / mullite / fiber composite contact materials

- LSCo perovskite offers very high electrical conductivity but also has high CTE (~18x10<sup>-6</sup>/°C) as cathode contact one needs to overcome the large residual stresses by:
- Reduce thermal stresses by adding low CTE phase mullite (~5.4x10<sup>-6</sup>/°C)
- Enhance the strength/toughness by reinforcement with strong short  $Al_2O_3$  fibers with high elastic modulus



## Validation Testing



## <u>Issues encountered with LSCo/mullite approach</u>

- Needs very high vol. fraction (~0.4) to match CTE in 12-13x10<sup>-6</sup>/°C
- Poor densification by sintering with rigid inclusions
- Poor strength with mullite at high volume fractions
- Poor conductivity with mullite at high volume fractions
- Potential contamination by Si in presence of moisture?
- Adding 5-10v%  $Al_2O_3$  improved strength and thermal cycle stability

Therefore investigating LSCo/Alumina Fiber composites

# LSCo/Al<sub>2</sub>O<sub>3</sub> fiber composite contact materials characterization



Pacific

Northwest

Poster: Composite Cathode Contact Development: An Investigation of LSCo/AI2O3(f) Composite



## /AI2O3(f) Composite (Matt Chou)

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# **Interconnect / BOP Coatings**

- Challenges
  - Metallic interconnects susceptible to oxidation (leading to high electrical resistance), Cr volatilization (leading to Cr poisoning), and reactions with seals (leading to mechanical failure)
  - Other metallic components susceptible to Cr volatilization
- Approaches
  - Electrically conductive Mn-Co spinel coatings exhibit good performance; due to possible issues with Co cost and availability, developing Co-free alternatives ✓ Cu-Mn-O; Ni-Mn-O; Cu-Fe-O
  - Reactive air aluminization for applications that don't require electrical conductivity
    - ✓ Simple slurry-based process
    - ✓ Fabrication in air at temperatures as low as 900°C

# **Co-free Electrically Conductive Protective Coatings**







EDS Layered Image 10

EDS Layered Image











DS Layered Image 18



## **Co-free Electrically Conductive Protective Coatings**



Poster: Short term stability of (M, Mn or Fe)3O4 spinel Layer for SOFC Stacks (Jung Pyung Choi)



# **Designed & Built Small-Scale SOFC Test Platform**

- Purpose:
  - Evaluate performance and reliability of emerging stack technologies (2-10 kW) under realistic operating conditions
- Test capabilities:
  - Steam-reformed methane
  - Steady-state isothermal tests
    - ✓ Variables: temperature, current, voltage, fuel
  - Thermal cycling
  - E-stop cycles (redox tolerance)
  - Variable anode recycle rates



- Validated the test platform in 500 hour test on reformed methane with 40% anode recycling – operated a 3.7 kW stack at 57% gross LHV efficiency
- Thereafter, various recycle rates were tested for effects on efficiency



# **Small-Scale SOFC Test Platform**

## Key features:

- Operation on methane via steam reforming
- Anode recirculation loop
- High efficiency microchannel heat exchangers for heat recuperation and anode/cathode stream temperature equalization
- Automated control system





# **Overview: Stack Modeling Tools**

## **Technical Challenge**

 SOFC stacks must be designed for high electrochemical performance and mechanical reliability

## **Modeling Objective**

 Develop numerical modeling tools to aid the industry teams' design and engineering efforts at the cell/stack scale

## **Technical Approach**

- SOFC-MP 2D Analysis of electrochemical and thermal performance of tall symmetric stacks
- **SOFC-MP 3D** Detailed 3D multi-cell stack structures for electrochemical, thermal, and stress analyses
- **SOFC-ROM** Reduced order models (ROMs) of SOFC stacks for use in system modeling analyses
- **GUI** Common interface for the modeling tools with pre-processing and post-processing capabilities

## **Recent Accomplishments**

- Implemented high-pressure operation in SOFC-MP
- Developed complete ROM generation tool
- Improved ROM exhaust species predictions through use of DNN and data normalization techniques
- Demonstrated dual mode degradation for prediction of end-of-life (EOL) performance
- Demonstration of SOFC tools for electrolysis mode



# **Program Modeling Objective: Linking Models Across Different Length Scales**

- Recent modeling activity has focused on *linking model results across length scales* 
  - Utilize a Reduced Order Model (ROM) approach to improve the accuracy of power system models





## System Models



**Reduced Order** Model (ROM)





# **Overview: Reduced Order Model (ROM)**

## **Technical Challenge**

• SOFC systems must be designed for high *efficiency* and low capital costs

## **Modeling Objective**

Improve accuracy and capability of SOFC systems analyses used for design and cost of energy (COE) predictions

## **Technical Approach**

- Integrate the PNNL SOFC-MP 2D model into NETL's system model as a *reduced-order model* (ROM)
  - Develop ROM that improves accuracy of the SOA SOFC analysis with reduced computational time and complexity
- Investigate machine learning (ML) approaches to *improve accuracy* and sensitivity of generated ROMs

## **Recent Accomplishments**

- Delivered numerous ROMs for different power system architectures to NETL collaborators
- Developed automated ROM construction tool and GUI to support local and remote solution on HPC cluster
  - Included error quantification for 95% confidence interval and sampling tool for high-dimensional parameter space
- Used machine learning methods to improve the prediction accuracy of stack exhaust species composition and classify case results
- Reviewed SOA electrochemical performance



# **ROM Generation**

- General process diagram for NGFC or **IGFC** power system
- Evaluated stack performance and thermal gradient for wide range of potential operating conditions
- Provided NETL collaborators with 27 ROMs for various configurations to support pathway studies
  - NGFC
  - IGFC (conventional, enhanced, catalytic)
  - SOA and future stack performance
  - System w/ or w/o carbon capture
  - System w/ or w/o vent gas recirculation concept



Input parameters	Range
Average current density (A/m <sup>2</sup> )	2000-6000
Fuel temperature (C)	15-600
Internal reforming (NA) *	0-1
Oxidant temperature (C)	550-800
Oxidant recirculation (NA)	0-0.8
Oxygen to carbon ratio (NA)	1.5-3
Stack fuel utilization (NA)	0.4-0.95
Stack oxidant utilization (NA)	0.0833-0.8
System pressure (ATM)	1-5
VGR temperature (C) **	15-204
VGR rate (NA) **	0.3-0.97

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* Only available
in NGFC
** Only available
in VGR



# **ROM Graphical User Interface (GUI)**

Put cases or

 Created a graphical user interface (GUI) and manual to allow a general user to more easily create a ROM using SOFC-MP stack results

1. Sampling	
SOFC-MP GUI Model Pre-Processing Simulation Post-Processing ROM Help	- <b>x</b>
ROM	
ROM Set Samplings Simulations Simulations on HPC Kinging Pro	ediction   Error Analysis and Additional Simulations   SmartSamp < 2 Analyzing Input Parameters in Samples
E:\Scratch\SOFC\NGFC_VGFV\NGFC_SOA_BVU_CCS_cases\LH Add samples from a file	# Input Variables 9 # Samples 512 Range
New Latin Hypercube Sampling	
	Display Samples in 2D space
	Display Samples in 3D space

## Poster: Reduced Order Models (ROMs) for SOFC Stack Performance Prediction (Jie Bao)

## 2. Create Cases and Solve

3	

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			-									BO	M Set	Sampling
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	Kriging Prediction	n Error Analysis and Additional Simulations	SmartSampling	Cross Validation	ML Prediction	< >
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## Build Kriging ROM

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ged solutions 🗹 Exclude all failed :	simulations
variables for Kriging	Display ROM Variables
^	Show range for a variable Range
_	✓
~	Show All ROM Input and Output Data
ect none	Contour plot for a selected variable over a selected 2D space
NGFC_SOA_BV0_CC	Variable for X-axis
ıt	Variable for Y-axis
	Variable for Z-axis
Output file name	Variable for Contour

## 4. ROM Prediction



# **ROM GUI Features**

Contr

Base SC

Voltage-current

function file

- Simplified creation of ROMs for different NGFC and IGFC system configurations w/ or w/o carbon capture and storage (CCS) and vent gas recirculation (VGR) options
- Smart sampling of more cases in regions of high mean square error
  - Local solution on PC
  - Remote solution on high performance computer (HPC)
- Cross validation of results to determine confidence interval of prediction
- Deep neural network (DNN) prediction option in addition to the standard Kriging prediction

	ROM						
	ROM Set Sampling	s Simulations	Simulatio	ns on HPC	Kriging	Prediction	Error Analys
	Use SOFC	MP2D4ROM W	rapper				
		CCS		Convention	al C	) IGFC Con	ventional VG
	○ NGFC	No CCS	O IGFC	Enhanced	0	) IGFC Enh	anced VGR
	O NGFC	CCS VGR		Catalytic	C	) IGFC Cata	lytic VGR
	Create/R	eset ROM Cases	;				
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FC-MP file	Smart sam	pling ?					

RMSE

Generate

itial sample





# **ROM w/ Machine Learning: Result Classification**

- Not all input parameter combinations are physically viable for the system
  - Developed classifier network to identify physically operational cases
  - Deep neural network (DNN) regression + DNN classifier + mass balance model (MBM) to improve prediction accuracy and reduce RMS error by 2-3X





# Stack State-of-Art Electrochemical Performance

- Reviewed voltage-current density (V-J) data within and outside the DOE SOFC program to ensure the best state-of-art (SOA) performance is being used for modeling simulations
- Challenges
  - Teams often report performance but do not provide enough data (i.e., stack details, conditions) to fully identify the V-J curve
  - Difficult to make 'apples-to-apples' comparisons
- **Observations** 
  - Multi-cell stacks not as good as single cells due to ohmic losses
  - All-ceramic cells not as good as planar anode-supported cells
  - For the SOFC program, FCE and Delphi stacks are top performers
  - Wide range of activation losses due different material sets
  - The best metal-supported cells are approaching performance of best anode-supported cells, so purported advantages in lower temperature operation and higher durability may drive it to be the prominent architecture
  - V-J data used for ROM activity is representative of current stacks



## Voltage-Current Density Plots



# **Overview: Short Term Reliability**

## **Technical Challenge**

• Stack operating stresses *dependent* on design, flow configuration, operating conditions and affect reliability

## **Modeling Objective**

• Investigate influence of stack design, geometry, fuel composition and *identify* conditions for high reliability

## **Technical Approach**

- Predict stack temperature distribution with different designs, geometry, flow configuration, and fuel compositions for NGFC systems using SOFC-MP
- Perform FEA stress analysis to predict operating and shutdown stresses and evaluate mechanical reliability
- Identify optimal operating conditions using design-ofexperiments approach with desirability function

## **Recent Accomplishments**

 Evaluated electrochemical/thermal performance and mechanical reliability of co- and counter-flow configurations for multi-cell stacks under similar operating conditions



# **Beginning of Life (BOL) 3D Stack Evaluations**

- Evaluated 15 and 45 cell large area stacks to understand the benefits of flow configuration and operating conditions on the relative performance at beginning of life (BOL)
- Counter-flow stacks generally had higher power and peak temperature but also higher temperature difference for similar operating states and average cell temperature
- Local peak temperatures at corners induced high stresses and predicted high local failure probability
- This was more influential than the • actual flow configuration effect
  - Reinforces importance of the sensitivity to realistic geometries and adequate fuel/oxidant manifold design



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# **Overview: Long Term Degradation**

## **Technical Challenge**

- *Bridge scales* of degradation from microstructure to stack
- Understand effect of creep

## **Modeling Objective**

- Identify operating conditions for optimal initial performance and minimal degradation
- Investigate effect of creep on SOFC mechanical reliability

## **Technical Approach**

- Evaluate stack performance with *multiple degradation mechanisms* acting independently and simultaneously
  - E.g., grain coarsening, Cr poisoning, scale growth, mechanical creep
- Evaluate BOL and *long-term reliability* of single and multicell stacks under realistic operating conditions.

## **Recent Accomplishments**

- Evaluated the performance and reliability of single and multi-cell SOFCs stacks under one or more degradation mechanisms
- Material creep model parameters were identified for the SOFC operational range  $(700 - 800^{\circ}C)$
- Evaluated influence of creep on stresses and reliability of generic multi-cell stack designs for realistic operating temperatures



# End of Life (EOL) 3D Stack Evaluations

- Evaluated 40k hour end of life (EOL) condition and mechanical reliability of 15 cell co- and counter-flow stacks experiencing mechanical creep
- Creep relaxation caused redistribution of stresses for both flow configurations that increased failure probabilities at the bottom cells of the stack
  - Potential for long-term damage in end cells nearest the load frame









# **Overview:** Damage **Progression**

## **Technical Challenge**

• Weibull analysis predicts 100% failure probability for components with localized (corner, edge) rupture. A better evaluation is needed for reliability predictions

## **Modeling Objective**

• Predict progressive damage of SOFC electrode and evaluate long-term reliability

## **Technical Approach**

- Investigate progressive damage models in literature and commercial FEA
- Develop and implement a *continuum brittle damage* mechanics constitutive model and validate with literature or experimental data.
- Evaluate progressive damage of electrodes in single and multicell stacks for reliability

## **Recent Accomplishments**

- Reviewed literature damage models for materials
- Implemented prediction of mechanical properties as a function of porosity
- Implemented a continuum damage mechanics model in FEA to evaluate damage evolution in the anode, electrolyte, and cathode layers
- Implemented a smeared crack model in FEA to evaluate damage evolution in the anode



# **Damage Models for SOFC Cell Materials**

- Continuum Damage Mechanics (CDM)
  - Constitutive theory that describes the progressive loss of material integrity due to the propagation and coalescence of micro-cracks, micro-voids, and similar defects
  - Voids, microcacks and pores are modeled as ellipsoidal inclusions and negligible stiffness in an Eshelby-Mori-Tanaka approach (EMTA) formulation averaged over all possible orientations
  - Typically phenomenological but focusing on *mechanistic* approach
- Smeared Crack Model (SCM)
  - Accounts for highly oriented nature of cracking (anisotropic nature) of the damaged stiffness and compliance matrices)
  - Considers both Mode-I (normal) and Mode-II (shear) resistances
  - Appropriate for quasi-brittle materials such as concrete or rock under predominantly tensile loading
  - Typical crack initiation based on maximum principal stress







 $\sigma = E\varepsilon^e \qquad \varepsilon = \varepsilon^e + \varepsilon^c$ 



# **Continuum Damage Mechanics (CDM) Model**

- Stiffness reduction law as a function of the void volume for porous material
- Develop constitutive relations and damage evolution laws
- Implement in FEA with stiffness reduction technique at a critical damage level

## Porosity Effect on Elastic Moduli

Ni/YSZ Strength Reduction Due to Damage





## **Poster: Progressive Damage in Planar Solid Oxide Fuel Cell Electrode Materials** (Naveen Karri)



# **Smeared Crack Model (SCM)**

- Degradation due to cracking represented without discrete crack modeling
- Considers reduced strengths in compression, tension and shear after cracking
- Easy to implement with fewer material parameters than the CDM model, this model is used often for modeling brittle damage in concrete structures

## **Predicted Temperature**



Anode Crack Density



## k modeling ar after cracking M model, this uctures



# Thank you

